

CMOS 8-Bit Microcontroller

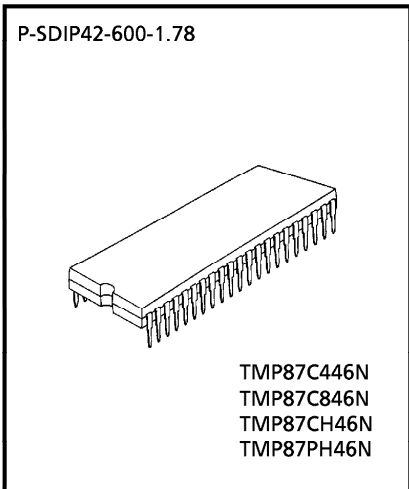
TMP87C446N, TMP87C846N, TMP87CH46N

87C446/846/H46 are high speed and high performance 8-bit single chip microcomputers. These MCU contain CPU core, ROM, RAM, input/output ports, an A/D converter, six multi-function timer/counters, a serial interface, a high speed serial output, and two clock generators on a chip.

Part No.	ROM	RAM	Package	OTP version
TMP87C446N	4 K × 8-bit	512 × 8-bit	P-SDIP42-600-1.78	TMP87PH46N
TMP87C846N	8 K × 8-bit			
TMP87CH46N	16 K × 8-bit			

Features

- ◆ 8-bit single chip microcomputer TLCS-870 Series
- ◆ Instruction execution time: 0.5 μ s (at 8 MHz), 122 μ s (at 32.768 kHz)
- ◆ 412 basic instructions
 - Multiplication and Division (8 bits × 8 bits, 16 bits ÷ 8 bits)
 - Bit manipulations (Set/Clear/Complement/Move/Test/Exclusive or)
 - 16-bit data operations
 - 1-byte jump/subroutine-call (Short relative jump / Vector call)
- ◆ 14 interrupt sources (External: 6, Internal: 8)
 - All sources have independent latches each, and nested interrupt control is available.
 - 4 edge-selectable external interrupts with noise reject
 - High-speed task switching by register bank changeover
- ◆ 5 Input/Output ports (35 pins)
 - High current output: 8 pins (typ. 20 mA)
- ◆ Two 16-bit Timer/Counters
 - Timer, Event counter, Programmable pulse generator output, Pulse width measurement, External trigger timer, Window modes
- ◆ Two 8-bit Timer/Counters
 - Timer, Event counter, Capture (Pulse width/duty measurement), PWM output, Programmable divider output modes
- ◆ Time Base Timer (Interrupt frequency: 1 Hz to 16 kHz)
- ◆ Divider output function (frequency: 1 kHz to 8 kHz)
- ◆ Watchdog Timer
- ◆ 8-bit Serial Interface
 - With 8 bytes transmit/receive data buffer
 - Internal/external serial clock, and 4/8-bit mode
- ◆ 8-bit High Speed Serial Output (rate: max. 1 bit / μ s)
- ◆ 8-bit successive approximate type A/D converter with sample and hold
 - 8 analog inputs
 - Conversion time: 23 μ s / 92 μ s at 8 MHz programmable selectable



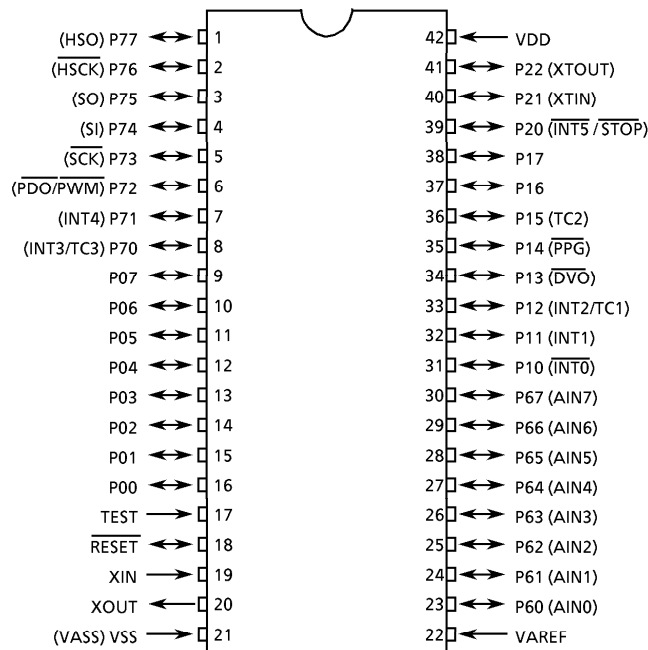
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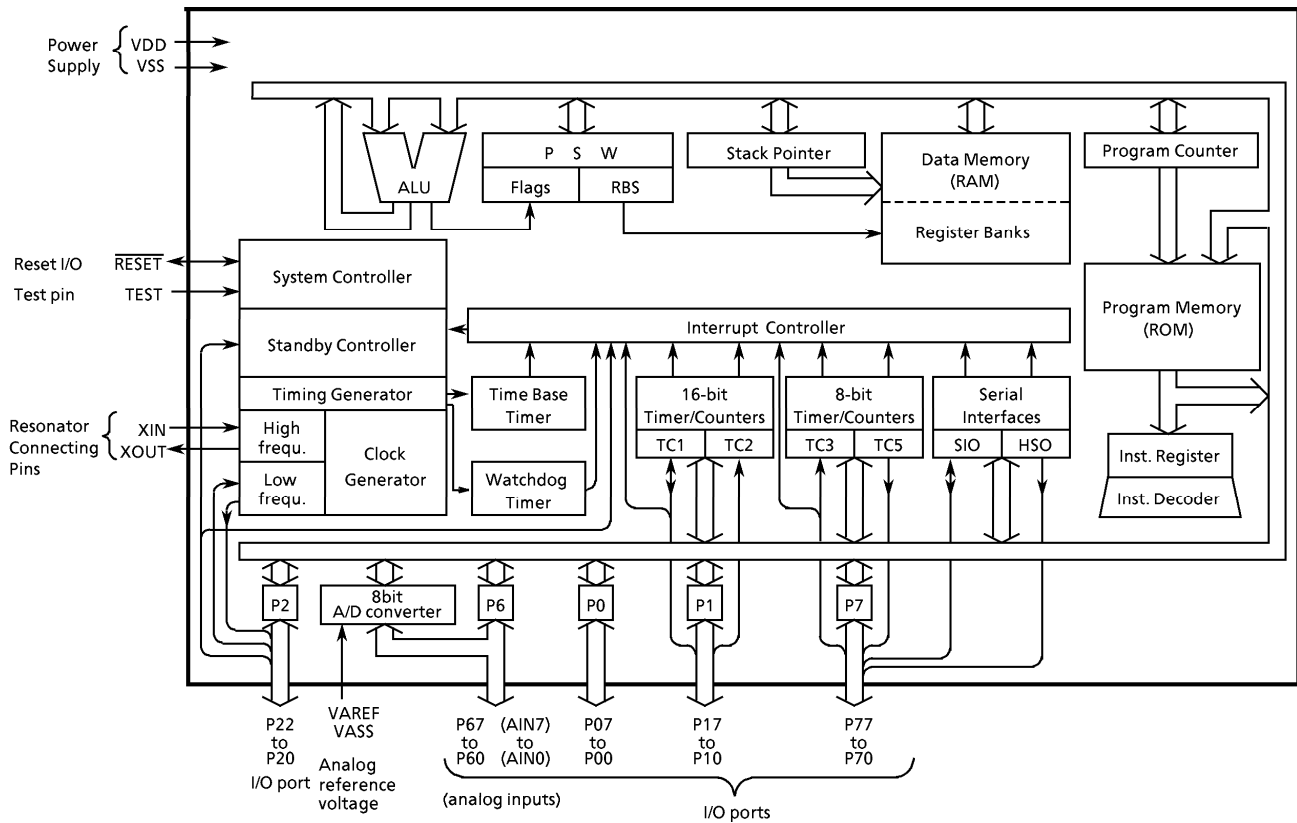
- ◆ Dual clock operation
- ◆ Five Power saving operating modes
 - STOP mode: Oscillation stops. Battery/Capacitor back-up.
Port output hold/high-impedance.
 - SLOW mode: Low power consumption operation using low-frequency clock (32.768 kHz).
 - IDLE1 mode: CPU stops, and Peripherals operate using high-frequency clock. Release by interrupts.
 - IDLE2 mode: CPU stops, and Peripherals operate using high and low frequency clock. Release by interrupts.
 - SLEEP mode: CPU stops, and Peripherals operate using low-frequency clock. Release by interrupts.
- ◆ Wide operating voltage: 2.7 to 5.5 V at 4.2 MHz / 32.768 kHz, 4.5 to 5.5 V at 8 MHz / 32.768 kHz
- ◆ Emulation Pod: BM87CH47U0A

Pin Assignments (Top View)

P-SDIP42-600-1.78



Block Diagram



Pin Function

Pin Name	Input / Output	Function	
P07 to P00	I/O	Two 8-bit programmable input/output ports (tri-state).	
P17, P16	I/O		
P15 (TC2)	I/O (Input)	Each bit of these ports can be individually configured as an input or an output under software control. During reset, all bits are configured as inputs. When used as a divider output or a PPG output, the latch must be set to "1".	Timer/Counter 2 input
P14 (PPG)	I/O (Output)		Programmable pulse generator output
P13 (DVO)			Divider output
P12 (INT2 / TC1)			External interrupt input 2 or Timer/Counter 1 input
P11 (INT1)	I/O (Input)		External interrupt input 1
P10 (INT0)			External interrupt input 0
P22 (XTOUT)	I/O (Output)	3-bit input/output port with latch. When used as an input port, the latch must be set to "1".	Resonator connecting pins (32.768kHz). For inputting external clock, XTIN is used and XTOUT is opened.
P21 (XTIN)	I/O (Input)		
P20 (INT5 / STOP)			
P67 (AIN7) to P60 (AIN0)	I/O (Output)	8-bit programmable input/output port (tri-state). Each bit of the port can be individually configured as an input or an output under software control.	A/D converter analog inputs
P77 (HSO)	I/O (Output)	8-bit programmable input/output port (tri-state).	HSO serial data output
P76 (HSCK)			HSO serial clock output
P75 (SIO)			SIO serial data output
P74 (SII)			SIO serial data input
P73 (SCK)	I/O (I/O)	When used as an input port, a SIO input/output, an external interrupt input or a PWM/PDO output, the latch must be set to "1".	SIO serial clock input/output
P72 (PWM / PDO)	I/O (Output)		8-bit PWM output or 8-bit programmable divider output
P71 (INT4)	I/O (Input)		External interrupt input 4
P70 (INT3 / TC3)			External interrupt input 3 or Timer/Counter 3 input
XIN, XOUT	Input, Output	Resonator connecting pins for high-frequency clock. For inputting external clock, XIN is used and XOUT is opened.	
RESET	I/O	Reset signal input or watchdog timer output/address-trap-reset output/system-clock-reset output.	
TEST	Input	Test pin for out-going test. Be tied to low.	
VDD, VSS	Power Supply	+ 5 V, 0 V (GND)	
VAREF		Analog reference voltage input	

OPERATIONAL DESCRIPTION

1. CPU CORE FUNCTIONS

The CPU core consists of a CPU, a system clock controller, an interrupt controller, and a watchdog timer. This section provides a description of the CPU core, the program memory (ROM), the data memory (RAM), and the reset circuit.

1.1 Memory Address Map

The TLCS-870 Series is capable of addressing 64K bytes of memory. Figure 1-1 shows the memory address maps of the 87C446/846/H46/447/847/H47/847L/H47L. In the TLCS-870 Series, the memory is organized 4 address spaces (ROM, RAM, SFR, and DBR). It uses a memory mapped I/O system, and all I/O registers are mapped in the SFR/DBR address spaces. There are 16 banks of general-purpose registers. The register banks are also assigned to the first 128 bytes of the RAM address space.

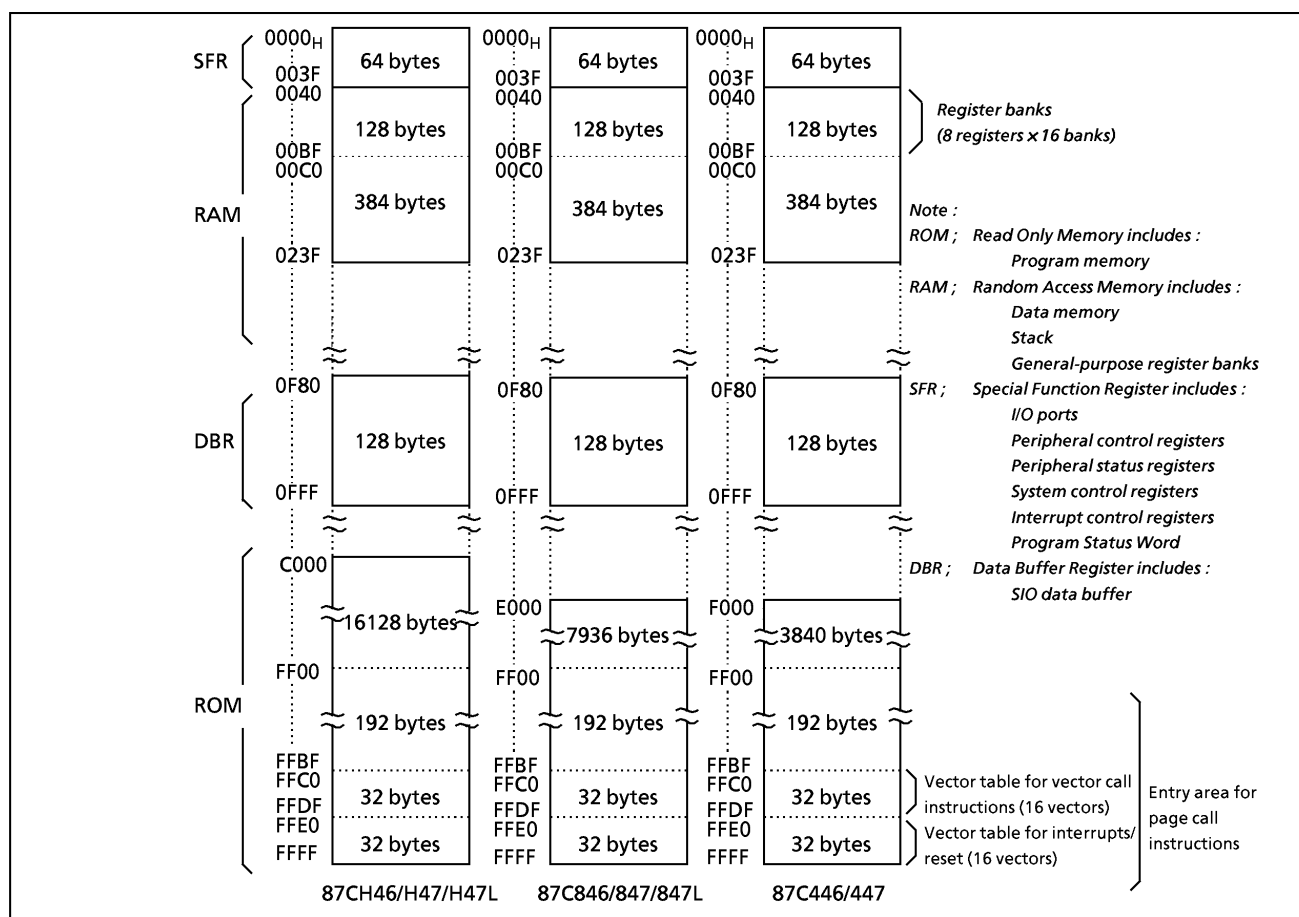


Figure 1-1. Memory Address Maps

Electrical Characteristics

(1) 87C446/846/H46/447/847/H47

Absolute Maximum Ratings ($V_{SS} = 0\text{ V}$)

Parameter	Symbol	Conditions	Ratings	Unit
Supply Voltage	V_{DD}		- 0.3 to 6.5	V
Input Voltage	V_{IN}		- 0.3 to $V_{DD} + 0.3$	V
Output Voltage	V_{OUT}		- 0.3 to $V_{DD} + 0.3$	V
Output Current (Per 1 pin)	I_{OUT1}	Ports P1, P2, P5, P6, P7	3.2	mA
	I_{OUT2}	Port P0	30	
Output Current (Total)	ΣI_{OUT1}	Ports P1, P2, P5, P6, P7	100	mA
	ΣI_{OUT2}	Port P0	120	
Power Dissipation [$T_{opr} = 70^\circ\text{C}$]	PD	87C446/846/H46	600	mW
		87C447/847/H47	350	
Soldering Temperature (time)	Tsld		260 (10 s)	$^\circ\text{C}$
Storage Temperature	Tstg		- 55 to 125	$^\circ\text{C}$
Operating Temperature	Topr		- 30 to 70	$^\circ\text{C}$

Note: The absolute maximum ratings are rated values which must not be exceeded during operation, even for an instant. Any one of the ratings must not be exceeded. If any absolute maximum rating is exceeded, a device may break down or its performance may be degraded, causing it to catch fire or explode resulting in injury to the user. Thus, when designing products which include this device, ensure that no absolute maximum rating value will ever be exceeded.

Recommended Operating Conditions ($V_{SS} = 0\text{ V}$, $T_{opr} = - 30\text{ to }70^\circ\text{C}$)

Parameter	Symbol	Pins	Conditions	Min	Max	Unit	
Supply Voltage	V_{DD}		$f_c = 8\text{ MHz}$	NORMAL1, 2 mode	4.5	5.5	V
				IDLE1, 2 mode			
			$f_c = 4.2\text{ MHz}$	NORMAL1, 2 mode	2.7		
				IDLE1, 2 mode			
			$f_s = 32.768\text{ kHz}$	SLOW mode	2.0		
SLEEP mode							
	STOP mode						
Input High Voltage	V_{IH1}	Except hysteresis input	$V_{DD} \geq 4.5\text{ V}$	$V_{DD} \times 0.70$	V_{DD}	V	
	V_{IH2}	Hysteresis input		$V_{DD} \times 0.75$			
	V_{IH3}			$V_{DD} < 4.5\text{ V}$			$V_{DD} \times 0.90$
Input Low Voltage	V_{IL1}	Except hysteresis input	$V_{DD} \geq 4.5\text{ V}$	0	$V_{DD} \times 0.30$	V	
	V_{IL2}	Hysteresis input		$V_{DD} \times 0.25$			
	V_{IL3}			$V_{DD} < 4.5\text{ V}$	$V_{DD} \times 0.10$		
Clock Frequency	f_c	XIN, XOUT	$V_{DD} = 4.5\text{ to }5.5\text{ V}$	1.0	8.0	MHz	
			$V_{DD} = 2.7\text{ to }5.5\text{ V}$		4.2		
	f_s	XTIN, XTOUT		30.0	34.0	kHz	

Note: The recommended operating conditions for a device are operating conditions under which it can be guaranteed that the device will operate as specified. If the device is used under operating conditions other than the recommended operating conditions (supply voltage, operating temperature range, specified AC/DC values etc.), malfunction may occur. Thus, when designing products which include this device, ensure that the recommended operating conditions for the device are always adhered to.

D.C. Characteristics ($V_{SS} = 0\text{ V}$, $T_{opr} = -30\text{ to }70^\circ\text{C}$)

Parameter	Symbol	Pins	Conditions	Min	Typ.	Max	Unit
Hysteresis Voltage	V_{HS}	Hysteresis inputs	$V_{DD} = 5.0\text{ V}$	–	0.9	–	V
Input Current	I_{IN1}	TEST	$V_{DD} = 5.5\text{ V}$ $V_{IN} = 5.5\text{ V}/0\text{ V}$	–	–	± 2	μA
	I_{IN2}	Open drain ports, Tri-state ports					
	I_{IN3}	RESET, STOP					
Input Resistance	R_{IN2}	RESET		100	220	450	$\text{k}\Omega$
Output Leakage Current	I_{LO1}	Sink open drain ports	$V_{DD} = 5.5\text{ V}$, $V_{OUT} = 5.5\text{ V}$	–	–	2	μA
	I_{LO2}	Tri-state ports	$V_{DD} = 5.5\text{ V}$, $V_{OUT} = 5.5\text{ V}/0\text{ V}$	–	–	± 2	
Output High Voltage	V_{OH2}	Tri-state ports	$V_{DD} = 4.5\text{ V}$, $I_{OH} = -0.7\text{ mA}$	4.1	–	–	V
Output Low Voltage	V_{OL}	Except XOUT and P0	$V_{DD} = 4.5\text{ V}$, $I_{OL} = 1.6\text{ mA}$	–	–	0.4	V
Output Low current	I_{OL3}	P0	$V_{DD} = 4.5\text{ V}$, $V_{OL} = 1.0\text{ V}$	–	20	–	mA
Supply Current in NORMAL 1, 2 modes	I_{DD}		$V_{DD} = 5.5\text{ V}$ $f_c = 8\text{ MHz}$ $f_s = 32.768\text{ kHz}$ $V_{IN} = 5.3\text{ V}/0.2\text{ V}$	–	8	14	mA
Supply Current in IDLE 1, 2 modes				–	4	6	
Supply Current in NORMAL 1, 2 modes			$V_{DD} = 3.0\text{ V}$ $f_c = 4.19\text{ MHz}$ $f_s = 32.768\text{ kHz}$ $V_{IN} = 2.8\text{ V}/0.2\text{ V}$	–	2.5	3.5	mA
Supply Current in IDLE 1, 2 modes				–	1.5	2.0	
Supply Current in SLOW mode			$V_{DD} = 3.0\text{ V}$ $f_s = 32.768\text{ kHz}$ $V_{IN} = 2.8\text{ V}/0.2\text{ V}$	–	30	60	μA
Supply Current in SLEEP mode				–	15	30	μA
Supply Current in STOP mode				$V_{DD} = 5.5\text{ V}$ $V_{IN} = 5.3\text{ V}/0.2\text{ V}$	–	0.5	

Note 1: Typical values show those at $T_{opr} = 25^\circ\text{C}$.
Note 2: Input Current I_{IN1}, I_{IN3} ; The current through resistor is not included, when the input resistor (pull-up or pull-down) is contained.
Note 3: I_{DD} ; Except for I_{REF}

A / D Conversion Characteristics ($V_{SS} = 0\text{ V}$, $V_{DD} = 4.5\text{ to }5.5\text{ V}$, $T_{opr} = -30\text{ to }70^\circ\text{C}$)

Parameter	Symbol	Conditions	Min	Typ.	Max	Unit
Analog Reference Voltage	V_{AREF}		2.7	–	V_{DD}	V
	V_{ASS}		V_{SS}			
Analog Input Voltage	V_{AIN}		V_{ASS}	–	V_{AREF}	V
Analog Supply Current	I_{REF}	$V_{AREF} = 5.5\text{ V}$, $V_{ASS} = 0.0\text{ V}$	–	0.5	1.0	mA
Nonlinearity Error		$V_{DD} = 5.0\text{ V}$ $V_{AREF} = 5.000\text{ V}$ $V_{ASS} (V_{SS}) = 0.000\text{ V}$ or $V_{DD} = 2.7\text{ V}$ $V_{AREF} = 2.700\text{ V}$ $V_{ASS} (V_{SS}) = 0.000\text{ V}$	–	–	± 1	LSB
Zero Point Error			–	–	± 1	
Full Scale Error			–	–	± 1	
Total Error			–	–	± 2	

Note: Quantizing Error is not contained in total Errors.

A.C. Characteristics

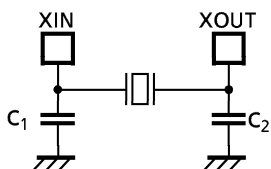
($V_{SS} = 0\text{ V}$, $V_{DD} = 4.5\text{ to }5.5\text{ V}$, $T_{opr} = -30\text{ to }70^\circ\text{C}$)

Parameter	Symbol	Conditions	Min	Typ.	Max	Unit
Machine Cycle Time	t_{cy}	In NORMAL 1, 2 mode	0.5	—	10	μs
		In IDLE 1, 2 mode				
		In SLOW mode	117.6	—	133.3	
		In SLEEP mode				
High Level Clock Pulse Width	t_{WCH}	For external clock operation (XIN input), $f_c = 8\text{ MHz}$	50	—	—	ns
Low Level Clock Pulse Width	t_{WCL}					
High Level Clock Pulse Width	t_{WSH}	For external clock operation (XTIN input), $f_s = 32.768\text{ kHz}$	14.7	—	—	μs
Low Level Clock Pulse Width	t_{WSL}					

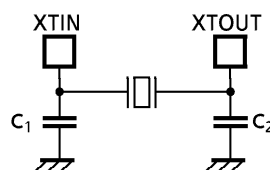
Recommended Oscillating Conditions

($V_{SS} = 0\text{ V}$, $V_{DD} = 4.5\text{ to }5.5\text{ V}$, $T_{opr} = -30\text{ to }70^\circ\text{C}$)

Parameter	Oscillator	Frequency	Recommended Oscillator	Recommended Condition	
				C_1	C_2
High-frequency	Ceramic Resonator	8 MHz	KYOCERA KBR8.0M	30 pF	30 pF
			MURATA CSA8.00MTz CSACS8.00MT CSTCS8.00MT		
		4 MHz	KYOCERA KBR4.0MS		
			MURATA CSAC4.00MGC CSA4.00MG		
Crystal Oscillator	8 MHz	TOYOCOM 210B 8.0000	20 pF	20 pF	
	4 MHz	TOYOCOM 204B 4.0000			
Low-frequency	Crystal Oscillator	32.768 kHz	NDK MX-38T	15 pF	15 pF



(1) High-frequency Oscillation



(2) Low-frequency Oscillation

Note: An electrical shield by metal shield plate on the surface of the IC package should be recommendable in order to prevent the device from the high electric field stress applied from CRT (Cathode Ray Tube) for continuous reliable operation.